## Notice of References Cited Application/Control No. 10/695,174 Examiner PHUC H. TRAN Applicant(s)/Patent Under Reexamination NAM ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
*	Α	US-2003/0041211	02-2003	Merkey et al.	711/114
*	В	US-6,314,110	11-2001	Chin et al.	370/468
*	С	US-7,126,910	10-2006	Sridhar, Kamakshi	370/229
*	D	US-5,706,278	01-1998	Robillard et al.	370/222
	Е	US-			
	F	US-			
	G	US-			
	Ξ	US-			
	_	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
<u></u>	Т				111111	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	`
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.